

SPECIFICATION

DEVICE NAME : Power MOSFET

TYPE NAME : 2SK2519-01

SPEC. No. :

Fuji Electric Co.,Ltd.

This Specification is subject to change without notice.

	DATE	NAME	APPROVED	Fuji Electric Co.,Ltd.		
DRAWN				DWG.NO.	1/11	
CHECKED						

1. Scope
This specifies Fuji power MOSFET 2SK2519-01
2. Construction N-channel enhancement mode power MOSFET
3. Application for switching
4. Outview T0-220 Outviwe See to 5/11 page
5. Absolute maximum ratings at Tc=25°C (unless otherwise specified)

Description	Symbol	Characteristics	Unit	Remarks
Drain-source voltage	V_{DS}	200	V	
Drain-gate voltage	V_{DGR}	200	V	$R_{GS} = 2.0 K\Omega$
Continuous Drain current	I_D	± 10	A	
Pulsed drain current	I_{DPULS}	± 40	A	
Gate-source voltage	V_{GS}	± 30	V	
Maximum power dissipation	P_D	40	W	
Operating and storage temperature range	T_{CH}	150	°C	
	T_{STG}	-55 ~ +150	°C	

6. Electrical characteristics at Tc=25°C (unless otherwise specified)
- Static ratings

Description	Symbol	Conditions	Characteristics			Unit
			Min.	Typ.	Max.	
Drain-source breakdown voltage	BV_{DSS}	$I_D = 1mA$ $V_{GS} = 0V$	200			V
Gate threshold voltage	$V_{GS(th)}$	$I_D = 1mA$ $V_{DS} = V_{GS}$	2.5	3.0	3.5	V
Zero gate voltage drain current	I_{DSS}	$V_{DS} = 200V$ $V_{GS} = 0V$	$T_{CH} = 25^\circ C$		500	μA
	I_{DSS}		$T_{CH} = 125^\circ C$		1.0	mA
Gate-source leakage current	I_{GSS}	$V_{GS} = \pm 30V$ $V_{DS} = 0V$		10	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$I_D = 5A$ $V_{GS} = 10V$		0.35	0.4	Ω

Dynamic ratings

Description	Symbol	Conditions	Characteristics			Unit
			Min.	Typ.	Max.	
Forward transconductance	g_{fs}	$I_D = 5\text{ A}$ $V_{DS} = 25\text{ V}$	2.0	4.5		S
Input capacitance	C_{iss}	$V_{DS} = 25\text{ V}$ $V_{GS} = 0\text{ V}$ $f = 1\text{ MHz}$		500	750	pF
Output capacitance	C_{oss}			110	170	pF
Reverse transfer capacitance	C_{rss}			50	80	pF
Turn-on time	$t_{d(on)}$	$V_{CC} = 150\text{ V}$ $V_{GS} = 10\text{ V}$ $I_D = 10\text{ A}$ $R_{GS} = 10\ \Omega$		10	20	ns
	t_r			30	50	ns
Turn-off time	$t_{d(off)}$			30	50	ns
	t_f			20	30	ns

Reverse diode

Description	Symbol	Conditions	Characteristics			Unit
			Min.	Typ.	Max.	
Avalanche capability	I_{AV}	$L = 100\ \mu\text{H}$, $T_{ch} = 25^\circ\text{C}$ * see Fig1 and Fig2	10.0			A
Diode forward on-voltage	V_{SD}	$I_F = 2 \times I_{DR}$ $V_{GS} = 0\text{ V}$, $T_{ch} = 25^\circ\text{C}$		1.15	1.8	V
Reverse recovery time	t_{rr}	$I_F = I_{DR}$ $V_{GS} = 0\text{ V}$ $-di_F/dt = 100\text{ A}/\mu\text{s}$ $T_{ch} = 25^\circ\text{C}$		130		ns
Reverse recovery charge	Q_{rr}				750	

7. Thermal resistance

Description	Symbol	Conditions	Characteristics			Unit
			Min.	Typ.	Max.	
Thermal resistance	$R_{th_{ch-c}}$				3.125	$^\circ\text{C}/\text{W}$
	$R_{th_{ch-a}}$				75.0	$^\circ\text{C}/\text{W}$

Fig.1 Test circuit

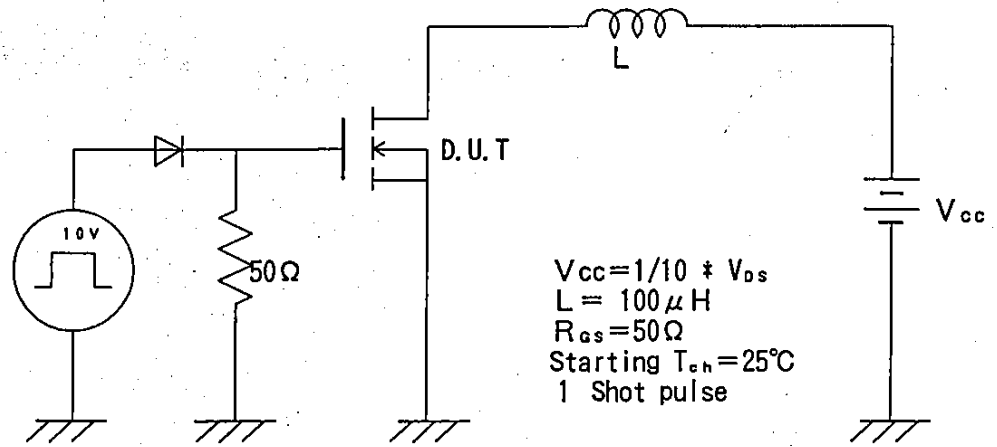
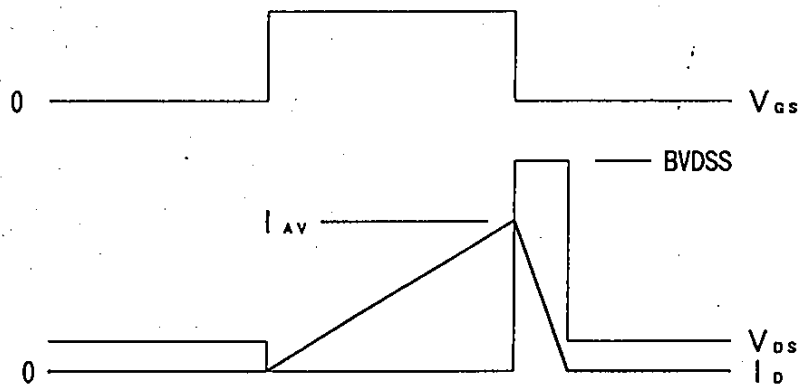
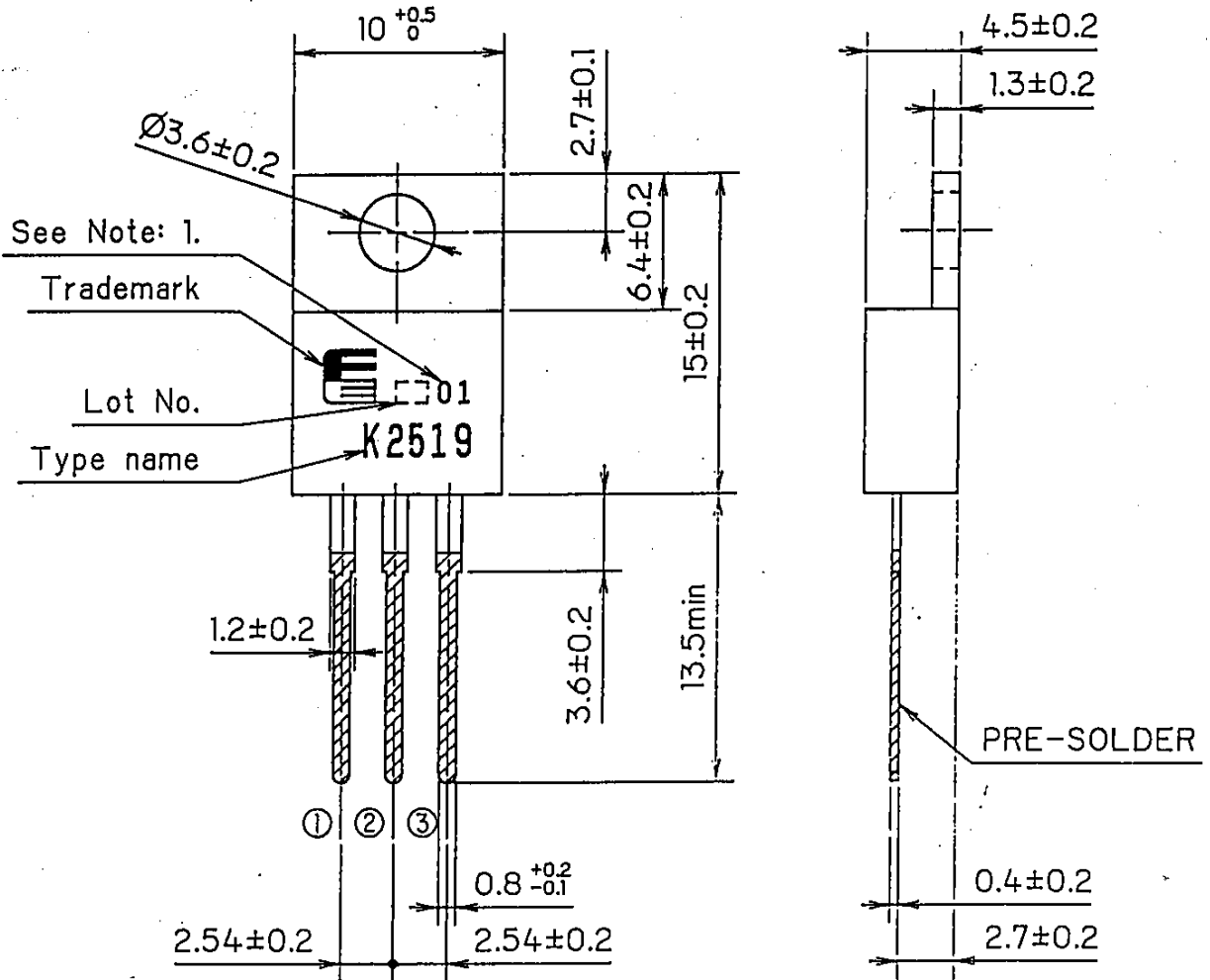


Fig.2 Operating waveforms

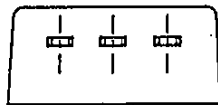


FUJI POWER MOS FET

TYPE : 2SK2519-01



CONNECTION



① ② ③

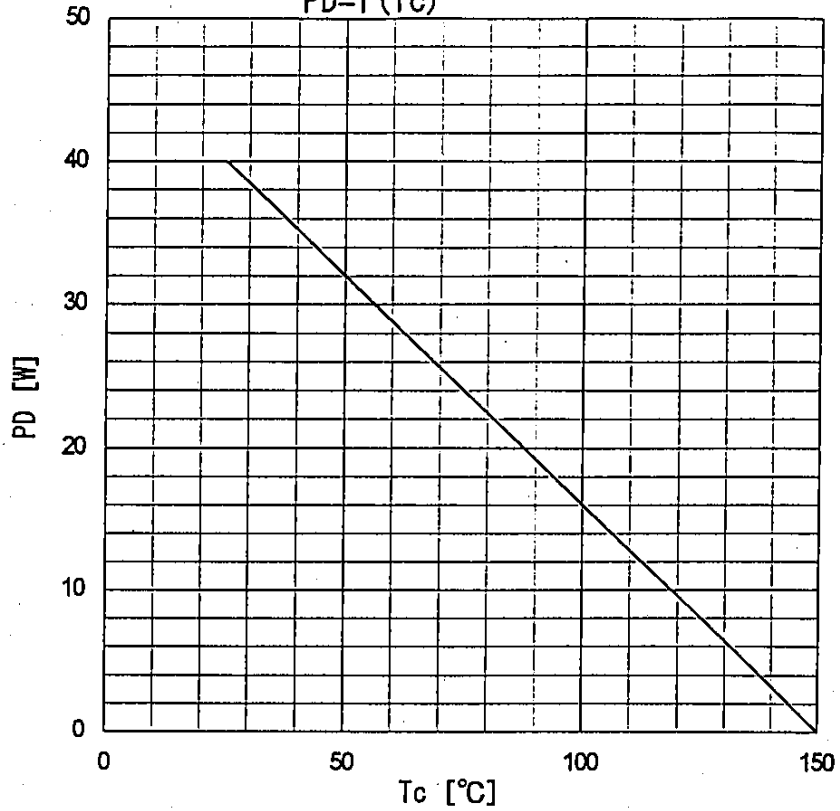
- ① GATE
- ② DRAIN
- ③ SOURCE

JEDEC : TO-220AB

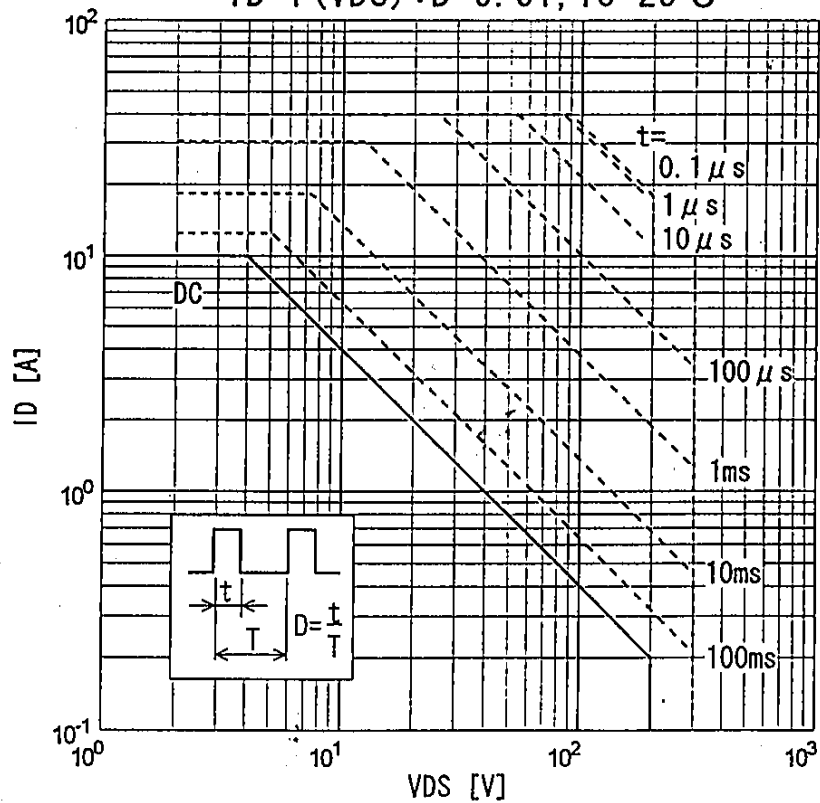
Note: 1. Guaranteed mark of avalanche ruggedness.

DIMENSIONS ARE IN MILLIMETERS.

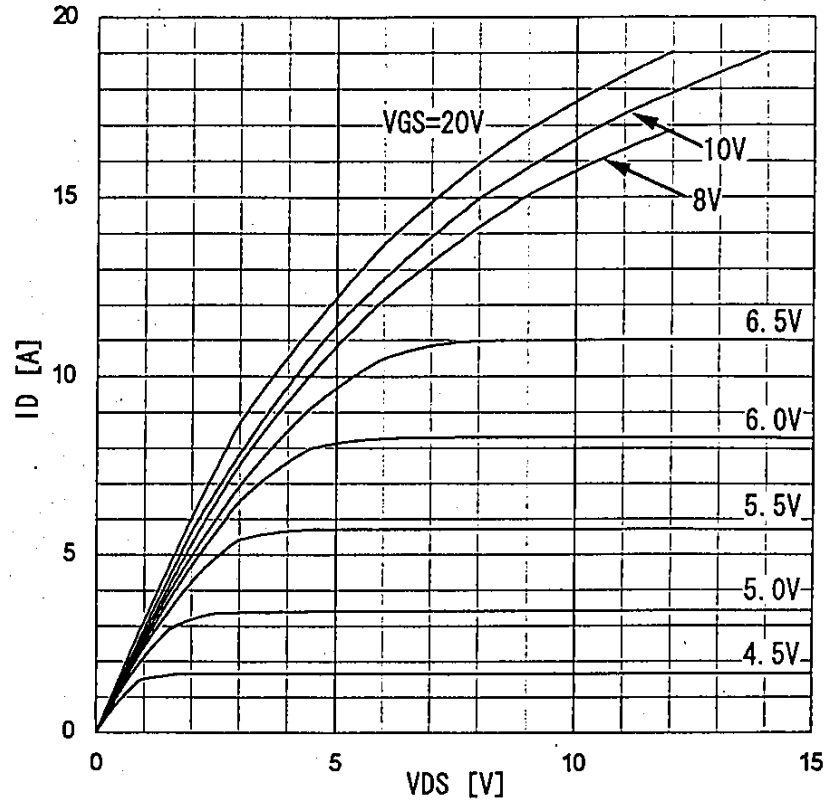
Power Dissipation
 $PD=f(T_c)$



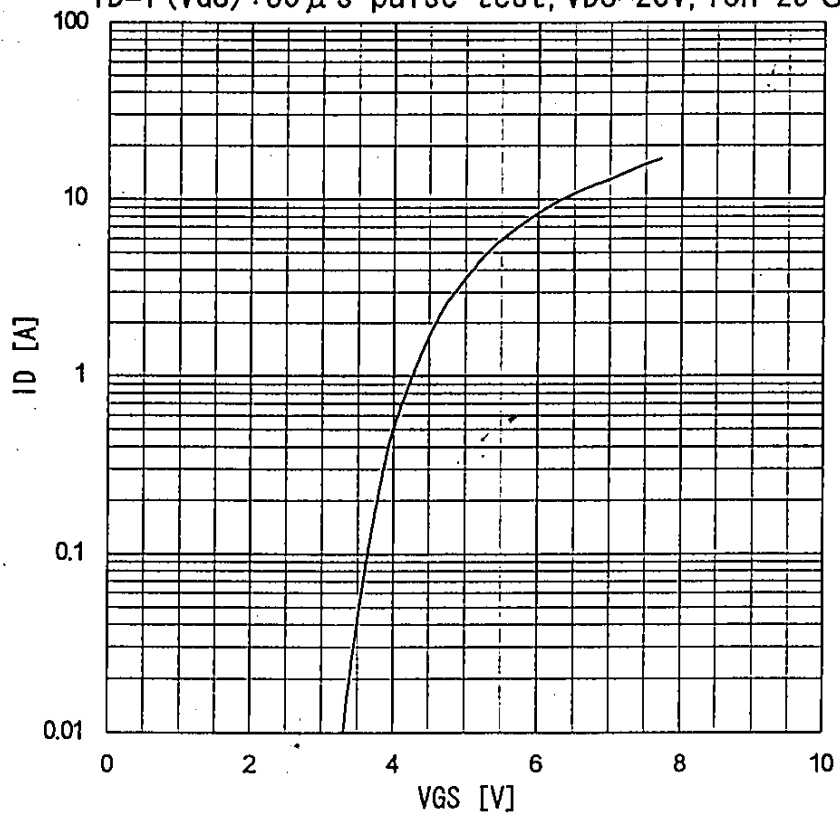
Safe operating area
 $ID=f(V_{DS}) : D=0.01, T_c=25^\circ\text{C}$



Typical output characteristics
 $I_D = f(V_{DS}) : 80 \mu s$ pulse test, $T_{ch} = 25^\circ C$

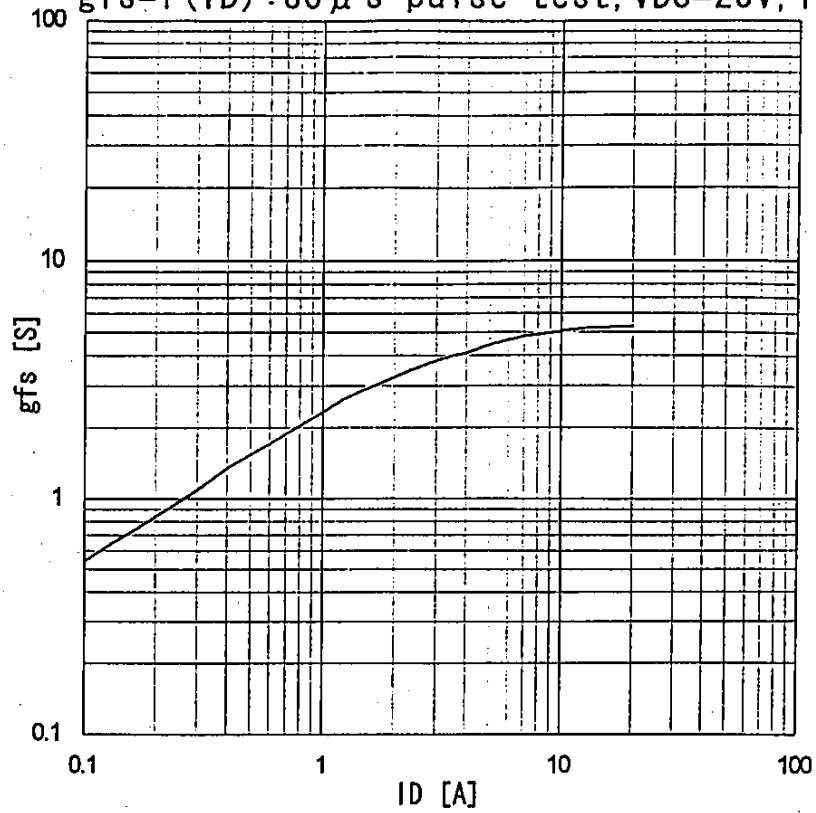


Typical transfer characteristic
 $I_D = f(V_{GS}) : 80 \mu s$ pulse test, $V_{DS} = 25V$, $T_{ch} = 25^\circ C$



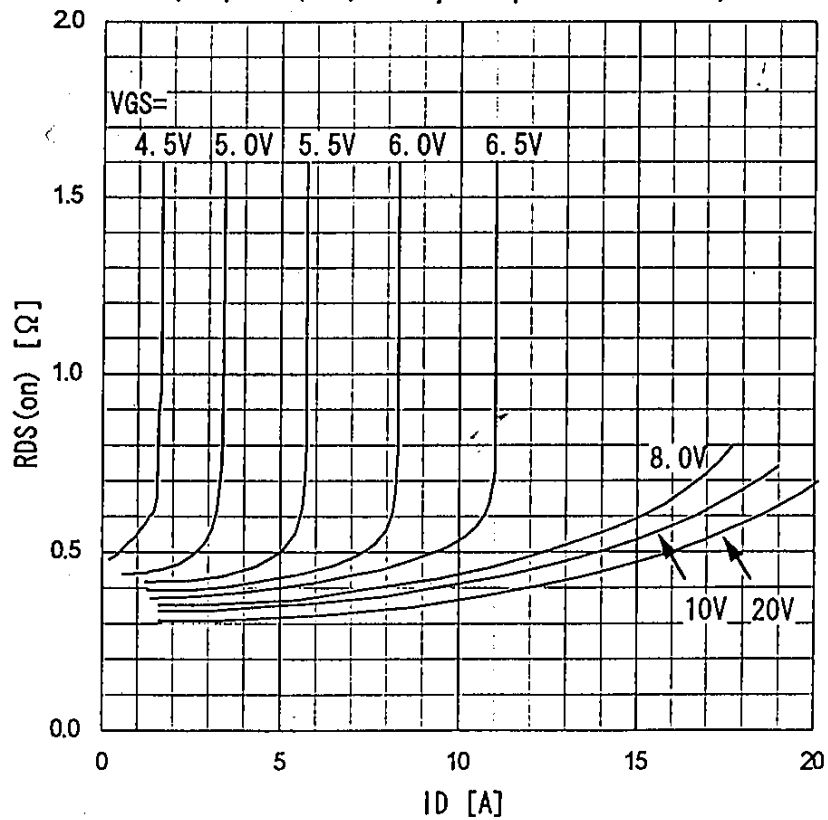
Typical transconductance

$g_{fs} = f(I_D) : 80 \mu s$ pulse test, $V_{DS} = 25V$, $T_{ch} = 25^\circ C$

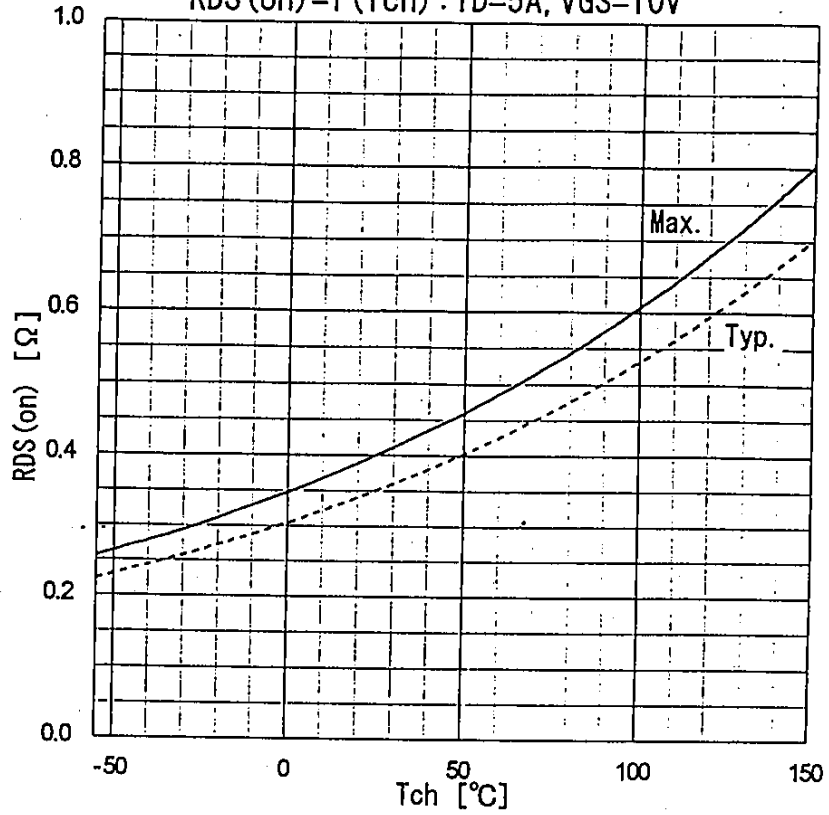


Typical drain-source on-state resistance

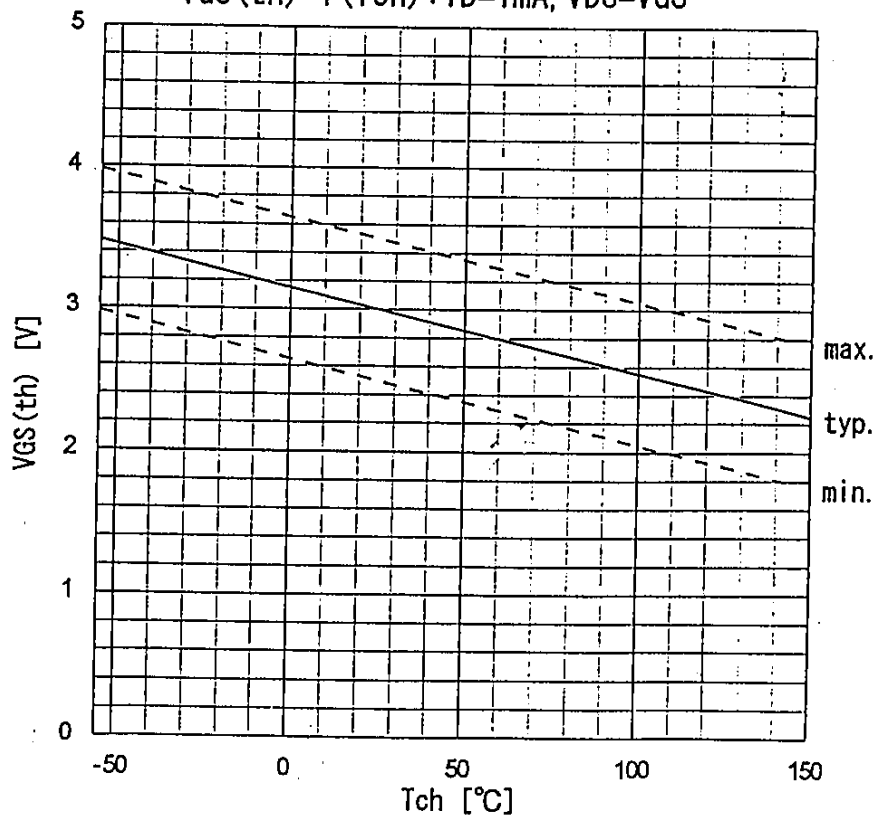
$R_{DS(on)} = f(I_D) : 80 \mu s$ pulse test, $T_{ch} = 25^\circ C$



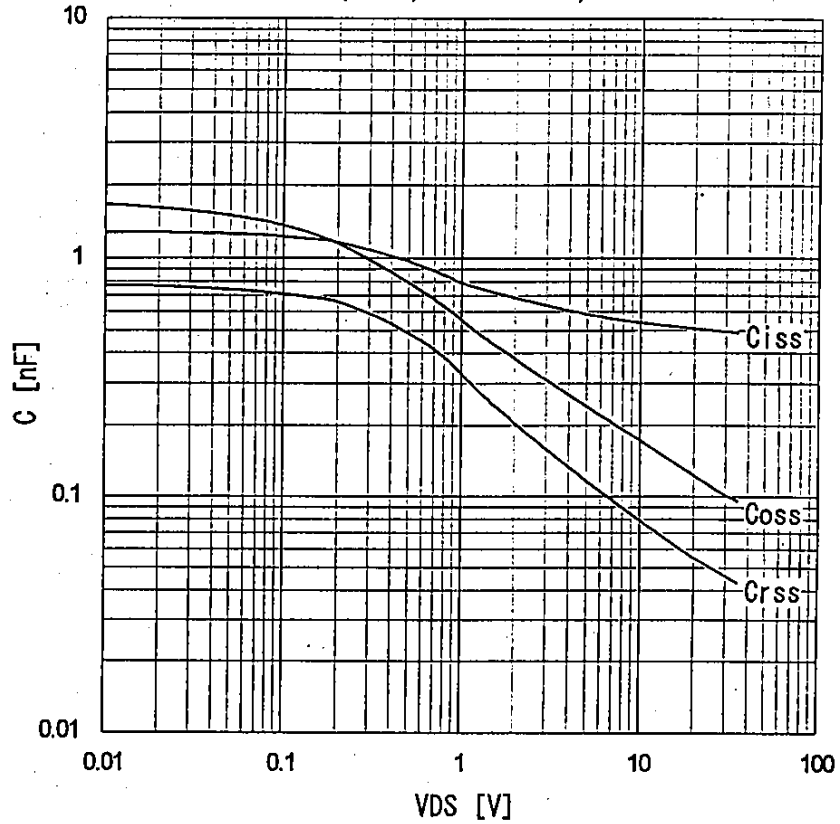
Drain-source on-state resistance
 $R_{DS(on)} = f(T_{ch}) : I_D = 5A, V_{GS} = 10V$



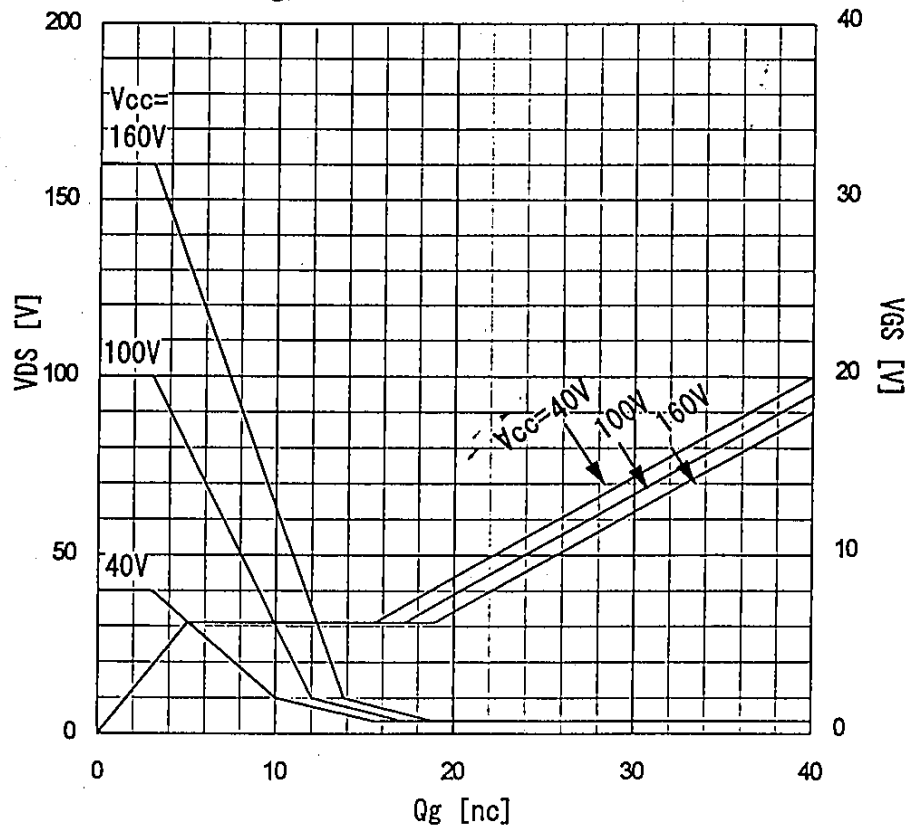
Gate threshold voltage
 $V_{GS(th)} = f(T_{ch}) : I_D = 1mA, V_{DS} = V_{GS}$



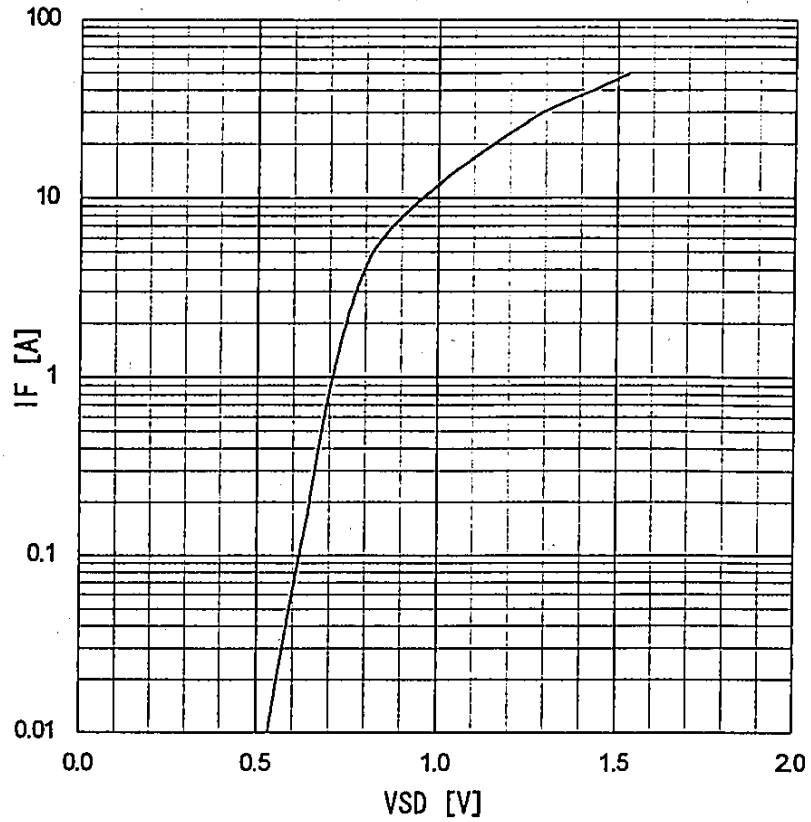
Typical Capacitances
 $C=f(V_{DS}) : V_{GS}=0V, f=1MHz$



Typical gate charge characteristics
 $V_{GS}=f(Q_g) : I_D=10A$



Forward characteristic of reverse diode
 $I_F = f(V_{SD}) : 80 \mu s$ pulse test $T_{ch} = 25^\circ C$ $V_{GS} = 0V$



Transient thermal impedance
 $Z_{th}(ch-c) = f(t)$ parameter: $D = t/T$

